

<b>Notice of References Cited</b>	Application/Control No. 10/754,082		Applicant(s)/Patent Under Reexamination SHELTON ET AL.	
	Examiner WANDA M. NEGRON		Art Unit 2622	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0040684	11-2001	TAKAHASHI, KENJI	358/1.2
*	B	US-5,724,579	03-1998	Suzuki, Takeshi	707/104.1
*	C	US-2002/0033958	03-2002	Sakamoto et al.	358/1.12
*	D	US-5,173,732	12-1992	Kazami et al.	355/55
*	E	US-6,018,397	01-2000	Cloutier et al.	358/1.1
*	F	US-2001/0015760	08-2001	FELLEGARA et al.	348/333.01
*	G	US-5,528,293	06-1996	Watanabe, Mikio	348/231.2
*	H	US-5,717,496	02-1998	Satoh et al.	358/402
*	I	US-6,097,900	08-2000	Haraguchi, Shosuke	396/287
*	J	US-2002/0191861	12-2002	Cheatle, Stephen Philip	382/282
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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